

## **Product Change Notification / KSRA-07GBXJ537**

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10-Mar-2021

## **Product Category:**

8-bit Microcontrollers

## **PCN Type:**

Manufacturing Change

## **Notification Subject:**

CCB 3546.002 Final Notice: Qualification of MTAI as an additional final test site for Atmel ATTiny414-SSF and ATTiny414-SSFR catalog part numbers (CPN) available in 14L SOIC package.

## **Affected CPNs:**

KSRA-07GBXJ537\_Affected\_CPN\_03102021.pdf KSRA-07GBXJ537\_Affected\_CPN\_03102021.csv

#### **Notification Text:**

PCN Status: Final notification.

PCN Type: Manufacturing Change

Microchip Parts Affected: Please open one of the files found in the Affected CPNs section.

NOTE: For your convenience Microchip includes identical files in two formats (.pdf and .xls).

**Description of Change:** Qualification of MTAI as an additional final test site for Atmel ATTiny414-SSF and ATTiny414-SSFR catalog part numbers (CPN) available in 14L SOIC package.

#### Pre and Post Change Summary:

	Pre Change	Post Change			
Final Test Site	Microchip Technology	Microchip Technology	Microchip		
	Operations (Philippines)	Operations (Philippines)	Technology Thailand		

		Corporation (MPHL)	Corporation (MPHL)	(HQ) (MTAI)			
Base Quantity	Tube	56	56	57			
Multiple (BQM)	Tape and Reel	3000	3000	3000			
Pin	Tape and Reel	Quadrant 1	Quadrant 1	Quadrant 1			
Orientation	Tube	See pre	and post change comparis	on.			
Car	rier tape	Ape No dimensional changes. See pre and post change comparison.					
Cov	ver Tape	No dimensional changes. See pre and post change comparison.					
	Reel	Color and minor dimensional changes. See pre and post change comparison.					
De	esiccant	See pre and post change comparison.					
Moisture Ba	Shielding Bag / rrier Bag Packing rocess	See pre and post change comparison.					
Cartor	n/Pizza box	Minor dimensional changes. See pre and post change comparison.					

Impacts to Data Sheet: None

Change Impact:None

**Reason for Change:**To improve manufacturability by qualifying MTAI as an additional final test site.

**Change Implementation Status:**In Progress

Estimated First Ship Date: April 10, 2021 (date code: 2115)

NOTE: Please be advised that after the estimated first ship date customers may receive pre and post change parts.

#### Time Table Summary:

	March 2021			April 2021					
Workweek	1 0	1 1	1 2	13	14	15	16	17	18
Qual Report Availability		Х							
Final PCN Issue Date		Χ							
Estimated						Χ			

Implementation					
Date					

Method to Identify Change: Traceability code

Qualification Report:Please open the attachments included with this PCN labeled as PCN\_#\_Qual\_Report.

**Revision History:March 10, 2021:** Issued final notification. Attached the Qualification Report. Provided estimated first ship date to be on April 10, 2021.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.

## Attachments:

PCN\_KSRA-07GBXJ537\_Pre and Post Change\_Summary.pdf PCN\_KSRA-07GBXJ537\_Qual Report.pdf

Please contact your local Microchip sales office with questions or concerns regarding this notification.

#### **Terms and Conditions:**

If you wish to <u>receive Microchip PCNs via email</u> please register for our PCN email service at our <u>PCN</u> home page select register then fill in the required fields. You will find instructions about registering for Microchips PCN email service in the <u>PCN FAQ</u> section.

If you wish to <u>change your PCN profile</u>, <u>including opt out</u>, please go to the <u>PCN home page</u> select login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections.

KSRA-07GBXJ537 - CCB 3546.002 Final Notice: Qualification of MTAI as an additional final test site for Atmel ATTiny414-SSF and ATTiny414-SSFR catalog part numbers (CPN) available in 14L SOIC package.
Affected Catalog Part Numbers (CPN)
ATTiny414-SSF
ATTINY414-SSFR
Date: Tuesday, March 09, 2021

# CCB 3546.002 Pre and Post Change Summary PCN# KSRA-07GBXJ537



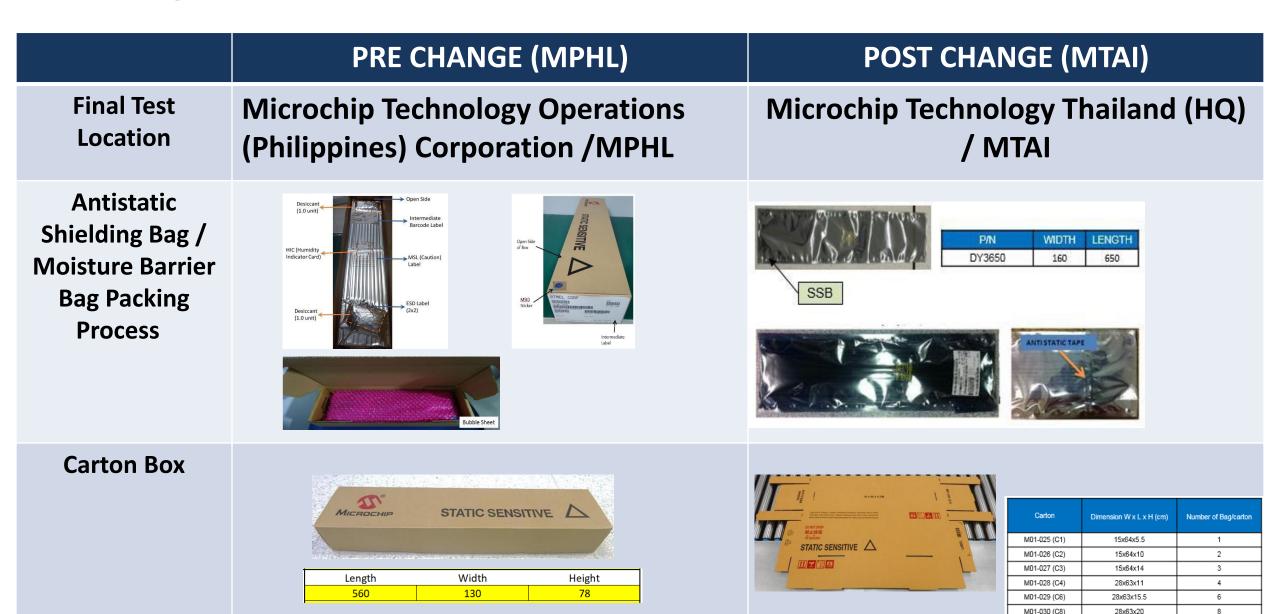
A Leading Provider of Smart, Connected and Secure Embedded Control Solutions



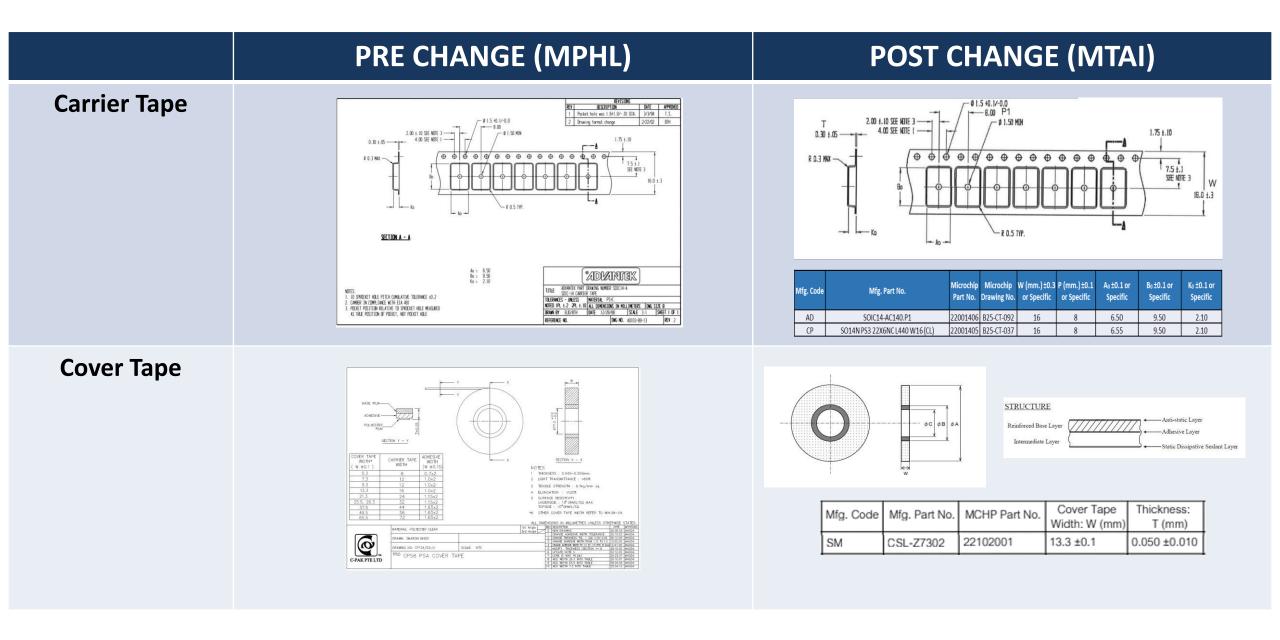
# **Packing Information –Tube**

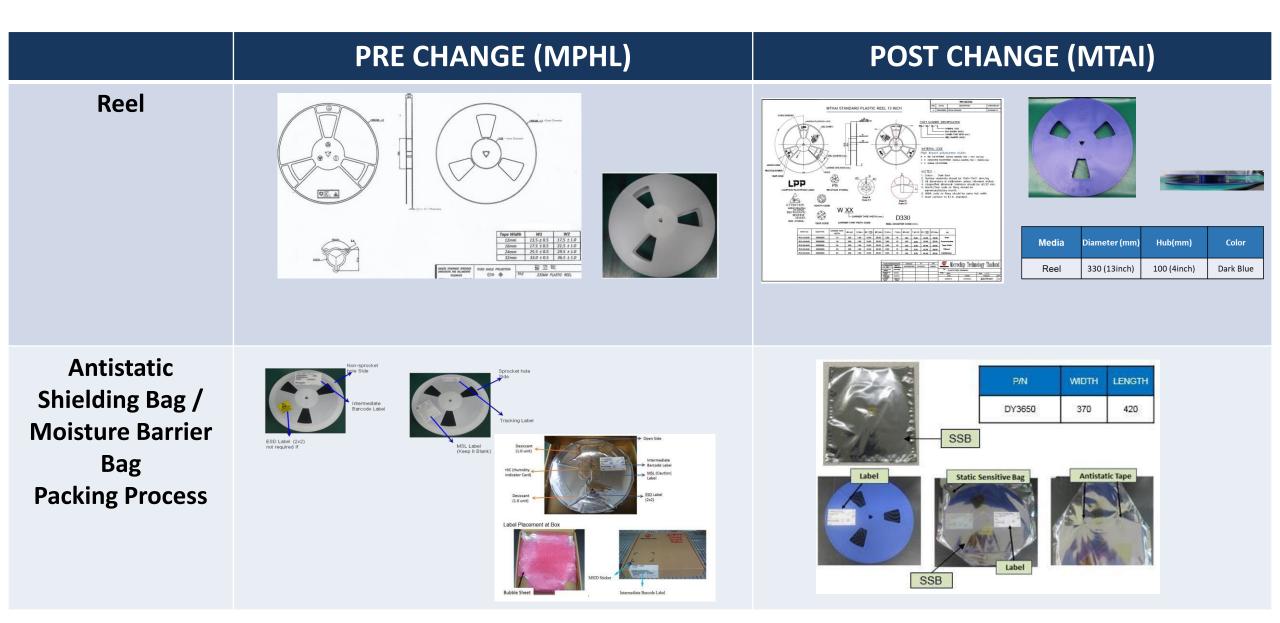
	PRE CHANGE (MPHL)	POST CHANGE (MTAI)
Final Test Location	Microchip Technology Operations (Philippines) Corporation / MPHL	Microchip Technology Thailand (HQ) / MTAI
Packing Media	Tube	Tube
Base Quantity Multiple (BQM)	56	57
Pin 1 Orientation	For SOIC  Pin #1 Direction  TATIC A 10-0501-00  C YYWW  End plug 1  End plug 2	Media Pin1 Side Opposite Side  TUBE White Black
With Desiccant and HIC?	1 unit Desiccant    Construction   C	Not Applicable

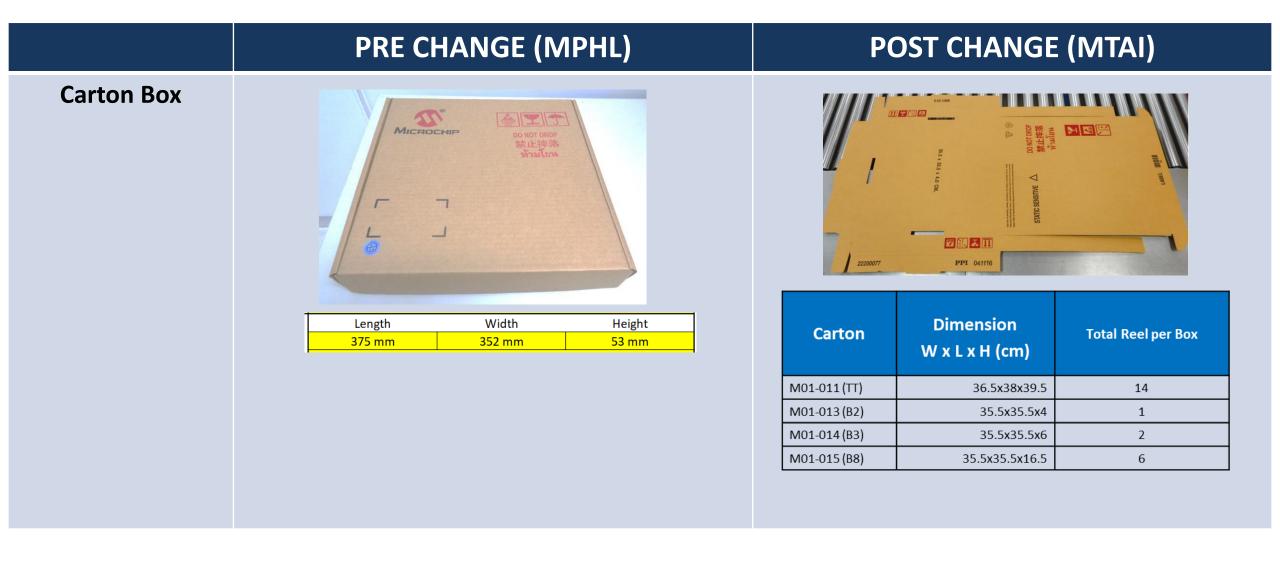
# **Packing Information –Tube**



	PR	ANGE (MPHL)	POST CHANGE (MTAI)				
Final Test Location	Microchip Technology Operations (Philippines) Corporation / MPHL				Microchip Technology Thailand (HQ) / MTAI		
Packing Media		Tape	e and Reel		Tape and Reel		
Base Quantity Multiple (BQM)			3000			30	00
Pin 1 Orientation	Quadrant 1	Media T/R	Carrier Tape  Quadrant 1		Quadrant 1	Media T/R	Pin1 Side  Carrier Tape  Quadrant 1
With Desiccant and HIC?		Programme of the control of the cont	Desiccant  Michael Maria  Michael Ma		No	t Applic	cable









## **QUALIFICATION REPORT SUMMARY**

PCN #: KSRA-07GBXJ537

Date February 25, 2021

Qualification of MTAI as an additional final test site for Atmel ATTiny414-SSF and ATTiny414-SSFR catalog part numbers (CPN) available in 14L SOIC package.

Purpose: Qualification of MTAI as an additional final test site for Atmel

ATTiny414-SSF and ATTiny414-SSFR catalog part numbers (CPN)

available in 14L SOIC package.

CCB No.: 3546.002

Test / Evaluation	Test Conditions / Parameters	Results
Datalog / Bin Comparison	<ul> <li>Compare test numbers, test names, test limit, test sequence, bin assignments &amp; pass/fail results.</li> <li>Accept if all match or justify the differences</li> </ul>	PASSED
Site by site verification	Verifies the channel map has the correct site assignments and tester/handler communication work correctly	PASSED
Correlation lot report	Yield at each step and reject analysis between systems. 5K units are tested for each program conversion we perform.      Accept on yield match within 1%	PASSED
Unit to unit parametric correlation	A full assembly strip characterized on both systems and graphed vs each other & the data sheet limits	PASSED
Test stability	50 loop test performed with no datalog delays     Accept on 0 fails	PASSED
Parametric test stability verification	Use Real Time Statistics software to create CPK report of all parametric tests	PASSED